


<b>Search Notes</b> 	<b>Application/Control No.</b> 10578071	<b>Applicant(s)/Patent Under Reexamination</b> IJZERMAN ET AL.
	<b>Examiner</b> JOHN HEYMAN	<b>Art Unit</b> 2871

SEARCHED			
Class	Subclass	Date	Examiner
349	15	02/28/2008	JSH
349	15	01/03/2009	JSH

SEARCH NOTES		
Search Notes	Date	Examiner
Consult Primary Examiner Andrew Schechter	02/27/ and 3/012008/	JSH
Text search entire Class 349	01/04/2009	JSH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--